Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/675,406	VIALLE ET AL.	
Examiner	Art Unit	
X. L. Bautista	2179	

SEARCHED					
Class	Subclass	Date	Examiner		
same as	prior search	12/26/2006	ХВ		
		-			
		;			
		-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		-			
_	.L				

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
EAST Search	12/26/2006	ХВ
Databases Searched: US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB		